

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination OSWALD ET AL.	
		Examiner SUMAN DEBNATH	Art Unit 2435	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-2003/0204856 A1	10-2003	Buxton, Mark J.	725/120
*	B US-2004/0267812 A1	12-2004	Harris et al.	707/104.1
*	C US-2002/0138576 A1	09-2002	Schleicher et al.	709/205
*	D US-6,907,763 B1	06-2005	Baulier, Dominique	72/312
*	E US-2006/0095792 A1	05-2006	Hurtado et al.	713/189
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.